

February 1992 Revised June 2001

74LVQ02

Low Voltage Quad 2-Input NOR Gate

General Description

The LVQ02 contains four 2-input NOR gates.

Features

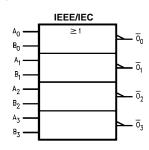
- Ideal for low power/low noise 3.3V applications
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- \blacksquare Guaranteed incident wave switching into 75 Ω

Ordering Code:

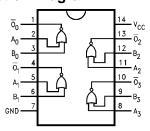
| Order Number | Package Number | Package Description | | | | | |
|--------------|----------------|--|--|--|--|--|--|
| 74LVQ02SC | M14A | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow | | | | | |
| 74LVQ02SJ | M14D | 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide | | | | | |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

| Pin Names | Description | | |
|---------------------------------|-------------|--|--|
| A _n , B _n | Inputs | | |
| \overline{O}_{n} | Outputs | | |

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC}) -0.5V to +7.0V

DC Input Diode Current (I_{IK})

 $\begin{array}{ccc} V_{I} = -0.5 V & -20 \text{ mA} \\ V_{I} = V_{CC} + 0.5 V & +20 \text{ mA} \\ \text{DC Input Voltage (V_{I})} & -0.5 V \text{ to } V_{CC} + 0.5 V \end{array}$

DC Output Diode Current (I_{OK})

 $V_{O} = -0.5V$ -20 mA $V_{O} = V_{CC} + 0.5V$ +20 mA

DC Output Voltage (V_O) -0.5V to $V_{CC} + 0.5V$

DC Output Source

or Sink Current (I_O) $\pm 50 \text{ mA}$

DC V_{CC} or Ground Current

 $\begin{array}{ll} (I_{CC} \text{ or } I_{GND}) & \pm 200 \text{ mA} \\ \text{Storage Temperature } (T_{STG}) & -65^{\circ}\text{C to } +150^{\circ}\text{C} \end{array}$

DC Latch-Up Source or

Sink Current ±100 mA

Recommended Operating Conditions (Note 2)

Supply Voltage (V_{CC})

Operating Temperature (T_A)

74LVQ -40° C to $+85^{\circ}$ C

Minimum Input Edge Rate (ΔV/Δt)

 V_{IN} from 0.8V to 2.0V

 $V_{CC} @ 3.0V$ 125 mV/ns

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

| Symbol | Parameter | v _{cc} | T _A = +25°C | | $T_A = -40^{\circ}C$ to $+85^{\circ}C$ | Units | Conditions | |
|------------------|---|-----------------|------------------------|------|--|-------|---|--|
| | | (V) | Typ Guaranteed Limits | | | | | |
| V _{IH} | Minimum High Level Input Voltage | 3.0 | 1.5 | 2.0 | 2.0 | V | V _{OUT} = 0.1V or V _{CC} - 0.1V | |
| V _{IL} | Maximum Low Level Input Voltage | 3.0 | 1.5 | 0.8 | 0.8 | ٧ | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ | |
| V _{OH} | Minimum High Level | 3.0 | 2.99 | 2.9 | 2.9 | V | $I_{OUT} = -50 \mu A$ | |
| | Output Voltage | 3.0 | | 2.58 | 2.48 | V | $V_{IN} = V_{IL}$ or V_{IH} (Note 3) $I_{OH} = -12$ mA | |
| V _{OL} | Maximum Low Level | 3.0 | 0.002 | 0.1 | 0.1 | V | $I_{OUT} = 50 \mu A$ | |
| | Output Voltage | 3.0 | | 0.36 | 0.44 | ٧ | $V_{IN} = V_{IL} \text{ or } V_{IH} \text{ (Note 3)}$ $I_{OL} = 12 \text{ mA}$ | |
| I _{IN} | Maximum Input Leakage Current | 3.6 | | ±0.1 | ±1.0 | μΑ | V _I = V _{CC} , GND | |
| I _{OLD} | Minimum Dynamic (Note 4) | 3.6 | | | 36 | mA | V _{OLD} = 0.8V Max (Note 5) | |
| I _{OHD} | Output Current | 3.6 | | | -25 | mA | V _{OHD} = 2.0V Min (Note 5) | |
| I _{CC} | Maximum Quiescent Supply Current | 3.6 | | 2.0 | 20.0 | μΑ | V _{IN} = V _{CC} or GND | |
| V _{OLP} | Quiet Output Maximum Dynamic V _{OL} | 3.3 | 0.6 | 1.0 | | ٧ | (Note 6)(Note 7) | |
| V _{OLV} | Quiet Output Minimum Dynamic V _{OL} | 3.3 | -0.7 | -1.0 | | ٧ | (Note 6)(Note 7) | |
| V _{IHD} | Maximum High Level Dynamic Input Voltage | 3.3 | 1.7 | 2.0 | | ٧ | (Note 6)(Note 8) | |
| V _{ILD} | Maximum Low Level Dynamic Input Voltage | 3.3 | 1.7 | 0.8 | | V | (Note 6)(Note 8) | |

Note 3: All outputs loaded; thresholds on input associated with output under test.

 $\textbf{Note 4:} \ \ \text{Maximum test duration 2.0 ms, one output loaded at a time.}$

Note 5: Incident wave switching on transmission lines with impedances as low as 75Ω for commercial temperature range is guaranteed for 74LVQ.

Note 6: Worst case package.

Note 7: Max number of outputs defined as (n). Data inputs are driven 0V to 3.3V; one output at GND.

Note 8: Max number of Data Inputs (n) switching. (n - 1) inputs switching 0V to 3.3V. Input-under-test switching: 3.3V to threshold (V_{ILD}), 0V to threshold (V_{IHD}), f = 1 MHz.

AC Electrical Characteristics

| Symbol Parameter | | V _{cc} | $T_A = +25$ °C $C_L = 50 \text{ pF}$ | | | $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $C_L = 50 \text{ pF}$ | | Units |
|---------------------|--------------------------------|-----------------|--------------------------------------|-----|------|---|------|-------|
| | | (V) | Min | Тур | Max | Min | Max | |
| t _{PLH} | Propagation Delay | 2.7 | 1.5 | 6.0 | 10.6 | 1.0 | 12.0 | |
| | | 3.3 ± 0.3 | 1.5 | 5.0 | 7.5 | 1.0 | 8.0 | ns |
| t _{PHL} | Propagation Delay | 2.7 | 1.5 | 6.0 | 10.6 | 1.0 | 12.0 | 20 |
| | | 3.3 ± 0.3 | 1.5 | 5.0 | 7.5 | 1.0 | 8.0 | ns |
| t _{OSHL} , | Output to Output Skew (Note 9) | 2.7 | | 1.0 | 1.5 | | 1.5 | 20 |
| t _{OSLH} | Data to Output | 3.3 ± 0.3 | | 1.0 | 1.5 | | 1.5 | ns |

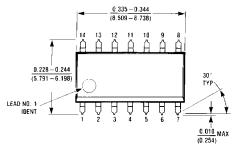
Note 9: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}). Parameter guaranteed by design.

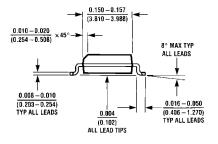
Capacitance

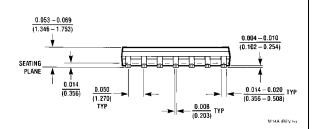
| Symbol | Parameter | Тур | Units | Conditions |
|---------------------------|-------------------------------|-----|-------|------------------------|
| C _{IN} | Input Capacitance | 4.5 | pF | V _{CC} = Open |
| C _{PD} (Note 10) | Power Dissipation Capacitance | 20 | pF | V _{CC} = 3.3V |

Note 10: C_{PD} is measured at 10 MHz.

Physical Dimensions inches (millimeters) unless otherwise noted







14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 10.2±0.1 -A-9.27 TYP 5.3±0.1 7.8 3.9 0.2 C B A PIN #1 IDENT. 1.27 TYP LAND PATTERN RECOMMENDATION SEE DETAIL A ALL LEAD TIPS 1.8±0.1 0.1 C -C-0.15-0.25 -1.27 TYP ⊕ 0.12 **(** C A DIMENSIONS ARE IN MILLIMETERS GAGE PLANE NOTES: 0.25 A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998. B. DIMENSIONS ARE IN MILLIMETERS. C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS. 0.60±0.15 SEATING PLANE M14DRevB1 DETAIL A

14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M14D

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com